YBCO Superconductors on Electrodeposited Biaxially Textured Buffer Layers

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Abstract—Non-vacuum electrodeposition (ED) was used to prepare simplified Gd₂O₃/Gd₂Zr₂O₇ and CeO₂/Gd₂Zr₂O₇ buffer layers on a Ni-W substrate. Post-annealing conditions of electrodeposited precursor films were optimized to obtain high-quality biaxially textured buffer layers. The buffer layers were characterized by X-ray diffraction, optical profiling, and transmission electron microscopy. The effect of the cap layer thickness on the surface morphology and texture of the buffers was also studied. The microstructure of CeO₂/Gd₂Zr₂O₇ was analyzed and compared to Gd₂O₃/Gd₂Zr₂O₇. YBa₂Cu₃O_{7-δ} (YBCO) superconductor was deposited by pulsed laser deposition (PLD) on the simplified ED-Gd₂O₃/Gd₂Zr₂O₇ and ED-CeO₂/Gd₂Zr₂O₇ buffers. Transport current density of 3.3 MA/cm² was obtained for PLD YBCO deposited on ED-Gd₂O₃/Gd₂Zr₂O₇ buffer layers.

Index Terms — Biaxial texture, buffer layers, electrodeposition, pulsed laser deposition, YBCO.

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